

## Product Summary

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>C</sub> = +25°C
30V	3.8mΩ @ V <sub>GS</sub> = 10V	145A
	6mΩ @ V <sub>GS</sub> = 4.5V	115A

## Description and Applications

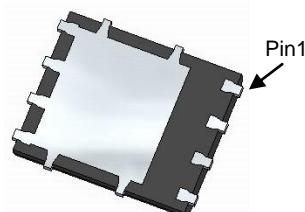
This MOSFET is designed to meet the stringent requirements of automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

- Backlighting
- Power Management Functions
- DC-DC Converters

POWERDI®5060-8



Top View



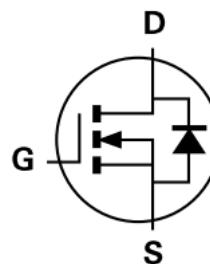
Bottom View

## Features and Benefits

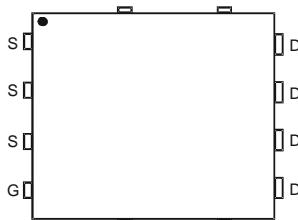
- Low R<sub>DS(ON)</sub> – Minimizes On-State Losses
- Excellent Q<sub>gd</sub> x R<sub>DS(ON)</sub> Product (FOM)
- Small Form Factor Thermally Efficient Package Enables Higher Density End Products
- 100% Unclamped Inductive Switching – Ensures More Reliability
- Rated to +175°C – Ideal for High Ambient Temperature Environments
- **Lead-Free Finish; RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability**
- **PPAP Capable (Note 4)**

## Mechanical Data

- Case: POWERDI®5060-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish — Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (E3)
- Weight: 0.097 grams (Approximate)



Internal Schematic



Top View  
Pin Configuration

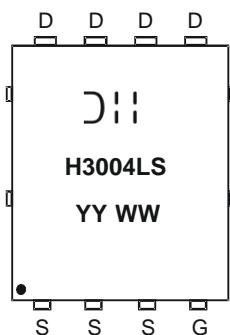
## Ordering Information (Note 5)

Part Number	Case	Packaging
DMTH3004LPSQ-13	POWERDI®5060-8	2,500/Tape & Reel

Notes:

1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
2. See [http://www.diodes.com/quality/lead\\_free.html](http://www.diodes.com/quality/lead_free.html) for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. Automotive products are AEC-Q101 qualified and are PPAP capable. Refer to [http://www.diodes.com/product\\_compliance\\_definitions.html](http://www.diodes.com/product_compliance_definitions.html).
5. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

## Marking Information



DII = Manufacturer's Marking  
H3004LS = Product Type Marking Code  
YYWW = Date Code Marking  
YY = Year (ex: 15 = 2015)  
WW = Week (01 to 53)

**Maximum Ratings** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		$V_{DSS}$	30	V
Gate-Source Voltage		$V_{GSS}$	+20 -16	V
Continuous Drain Current (Note 6)	$T_A = +25^\circ\text{C}$ $T_A = +100^\circ\text{C}$	$I_D$	22 16	A
Continuous Drain Current (Note 7)	$T_C = +25^\circ\text{C}$ $T_C = +100^\circ\text{C}$	$I_D$	145 103	A
Maximum Continuous Body Diode Forward Current		$I_S$	100	A
Pulsed Drain Current (10 $\mu\text{s}$ Pulse, Duty Cycle = 1%)		$I_{DM}$	180	A
Avalanche Current, L=0.3mH		$I_{AS}$	27	A
Avalanche Energy, L=0.3mH		$E_{AS}$	110	mJ

**Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Total Power Dissipation	$P_D$	136	W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	47	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction to Case (Note 7)	$R_{\theta JC}$	1.1	
Operating and Storage Temperature Range	$T_J, T_{STG}$	-55 to +175	$^\circ\text{C}$

**Electrical Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS</b> (Note 8)						
Drain-Source Breakdown Voltage	$BV_{DSS}$	30	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	$I_{DSS}$	—	—	1	$\mu\text{A}$	$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}$
Zero Gate Voltage Drain Current (Note 9)	$I_{DSS}$	—	—	10	$\mu\text{A}$	$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}$ $T_J = +125^\circ\text{C}$
Gate-Source Leakage	$I_{GSS}$	—	—	$\pm 100$	nA	$V_{GS} = +20\text{V}, V_{DS} = 0\text{V}$ $V_{GS} = -16\text{V}, V_{DS} = 0\text{V}$
<b>ON CHARACTERISTICS</b> (Note 8)						
Gate Threshold Voltage	$V_{GS(TH)}$	1	1.6	3	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	3.3	3.8	$\text{m}\Omega$	$V_{GS} = 10\text{V}, I_D = 20\text{A}$
		—	5	6		$V_{GS} = 4.5\text{V}, I_D = 7\text{A}$
Diode Forward Voltage	$V_{SD}$	—	0.70	1	V	$V_{GS} = 0\text{V}, I_S = 1\text{A}$
<b>DYNAMIC CHARACTERISTICS</b>						
Input Capacitance (Note 9)	$C_{iss}$	—	2370	—	$\text{pF}$	$V_{DS} = 15\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$
Output Capacitance (Note 9)	$C_{oss}$	—	1360	—		
Reverse Transfer Capacitance (Note 9)	$C_{rss}$	—	240	—		
Gate Resistance	$R_g$	0.14	0.7	1.75	$\Omega$	$V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$
<b>SWITCHING CHARACTERISTICS</b> (Note 9)						
Total Gate Charge ( $V_{GS} = 10\text{V}$ )	$Q_g$	—	43.7	—	$\text{nC}$	$V_{DS} = 15\text{V}, I_D = 20\text{A}$
Gate-Source Charge	$Q_{gs}$	—	6.9	—		
Gate-Drain Charge	$Q_{gd}$	—	8	—		
Turn-On Delay Time	$t_{D(ON)}$	—	6.2	—	$\text{ns}$	$V_{DD} = 15\text{V}, V_{GS} = 10\text{V}, R_G = 3\Omega, R_L = 0.75\Omega$
Turn-On Rise Time	$t_R$	—	4.2	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	21	—		
Turn-Off Fall Time	$t_F$	—	8	—		
Body Diode Reverse Recovery Time	$t_{RR}$	—	25	—	$\text{ns}$	$I_F = 15\text{A}, dI/dt = 500\text{A}/\mu\text{s}$
Body Diode Reverse Recovery Charge	$Q_{RR}$	—	37	—		

Notes:

6. Device mounted with exposed drain pad on 25mm by 25mm 2oz copper on a single- sided 1.6mm FR-4 PCB; device is measured under still air conditions whilst operating in a steady state.
7. Thermal resistance from junction to soldering point (on the exposed drain pad).
8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to production testing.

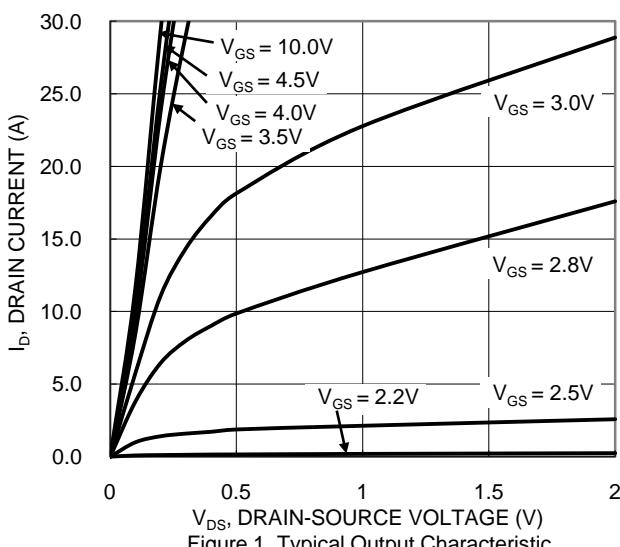


Figure 1. Typical Output Characteristic

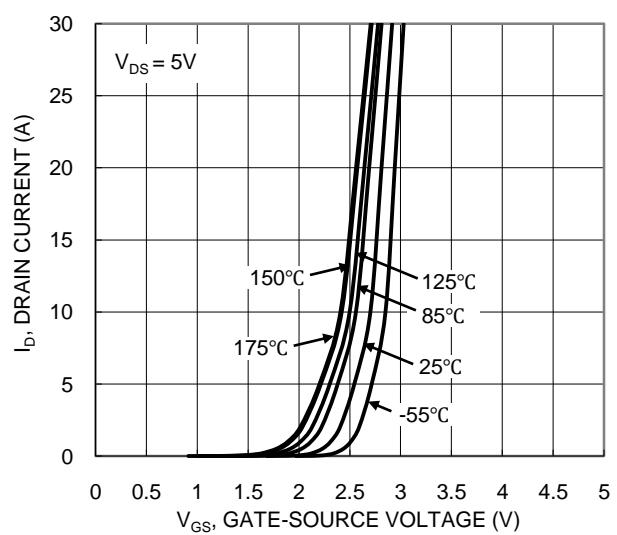


Figure 2. Typical Transfer Characteristic

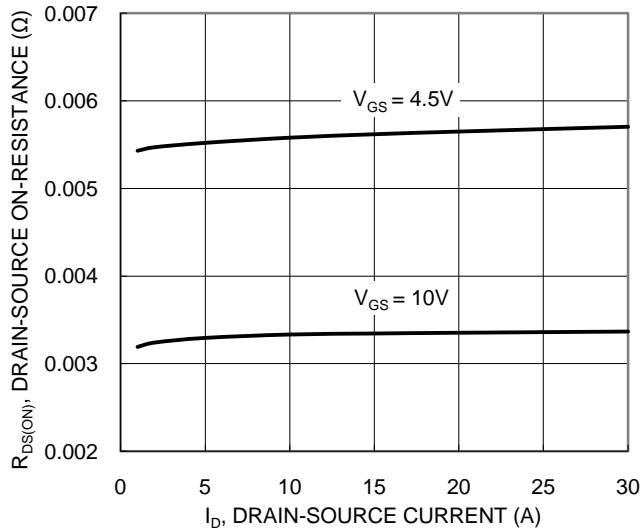


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

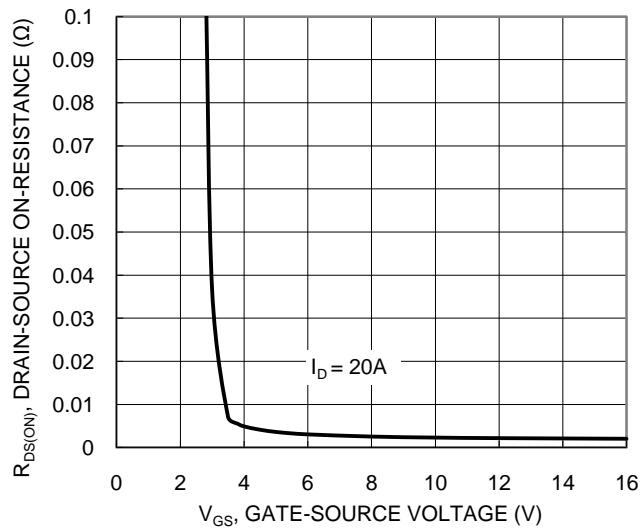


Figure 4. Typical Transfer Characteristic

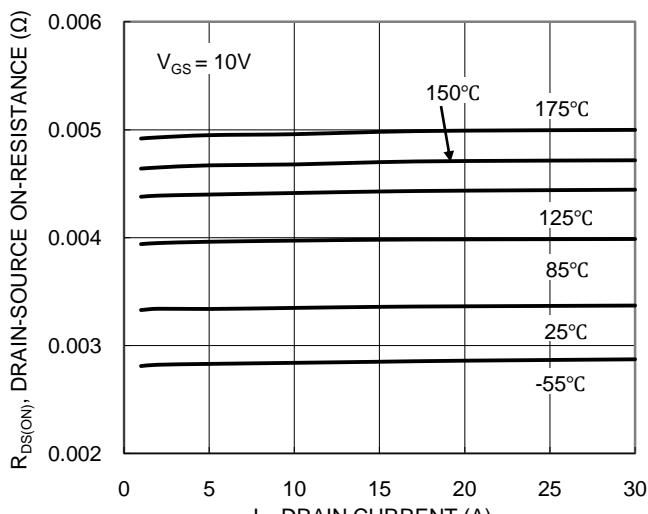


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

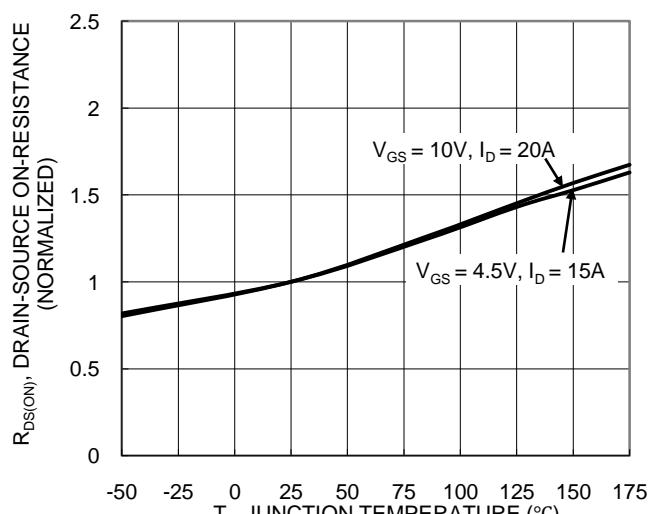


Figure 6. On-Resistance Variation with Junction Temperature

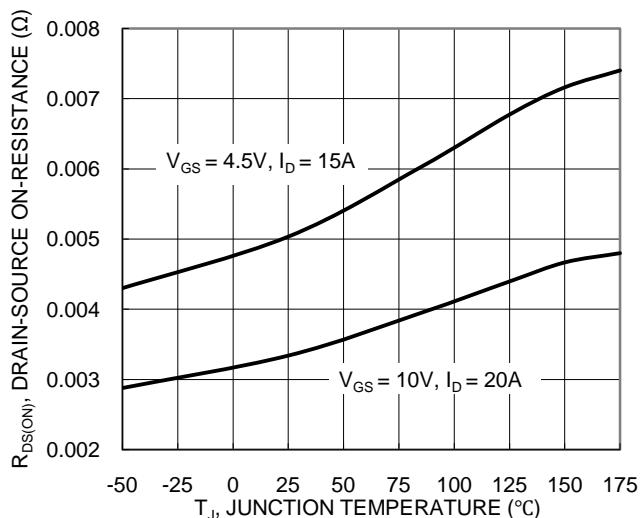


Figure 7. On-Resistance Variation with Junction Temperature

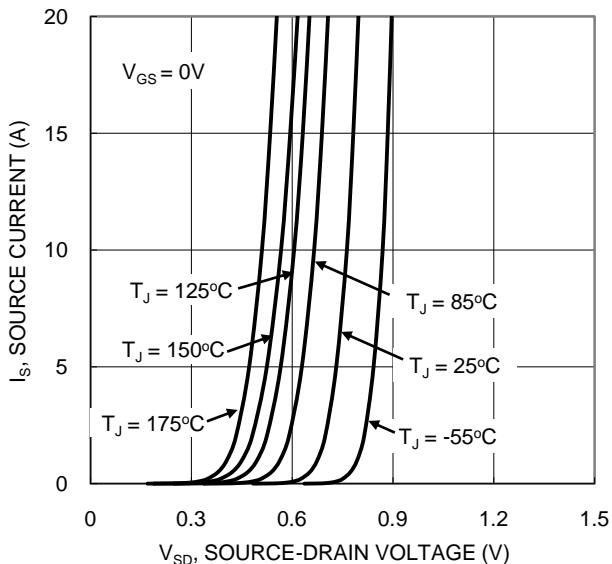


Figure 9. Diode Forward Voltage vs. Current

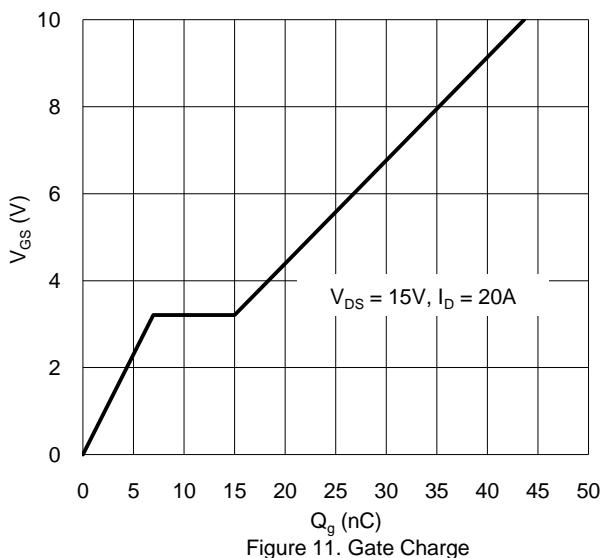


Figure 11. Gate Charge

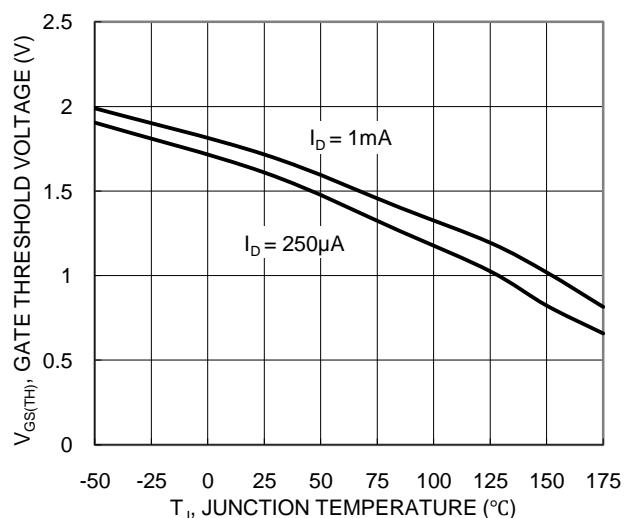


Figure 8. Gate Threshold Variation vs. Junction Temperature

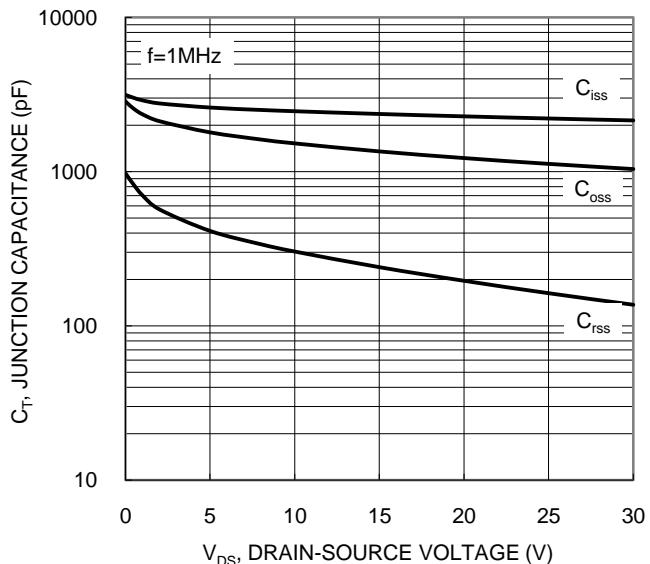


Figure 10. Typical Junction Capacitance

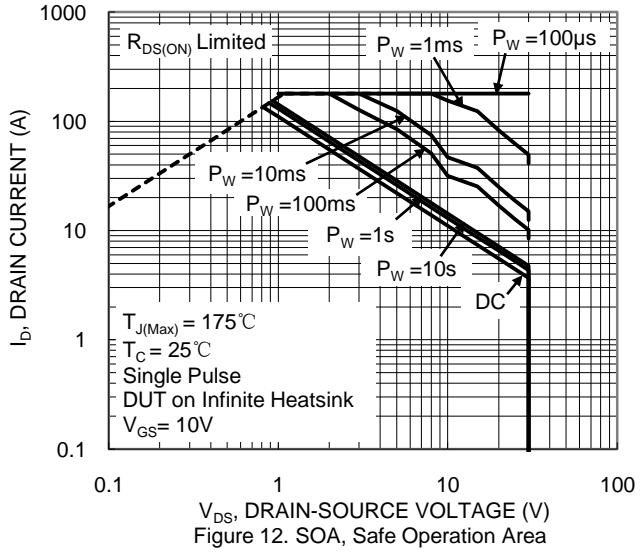


Figure 12. SOA, Safe Operation Area

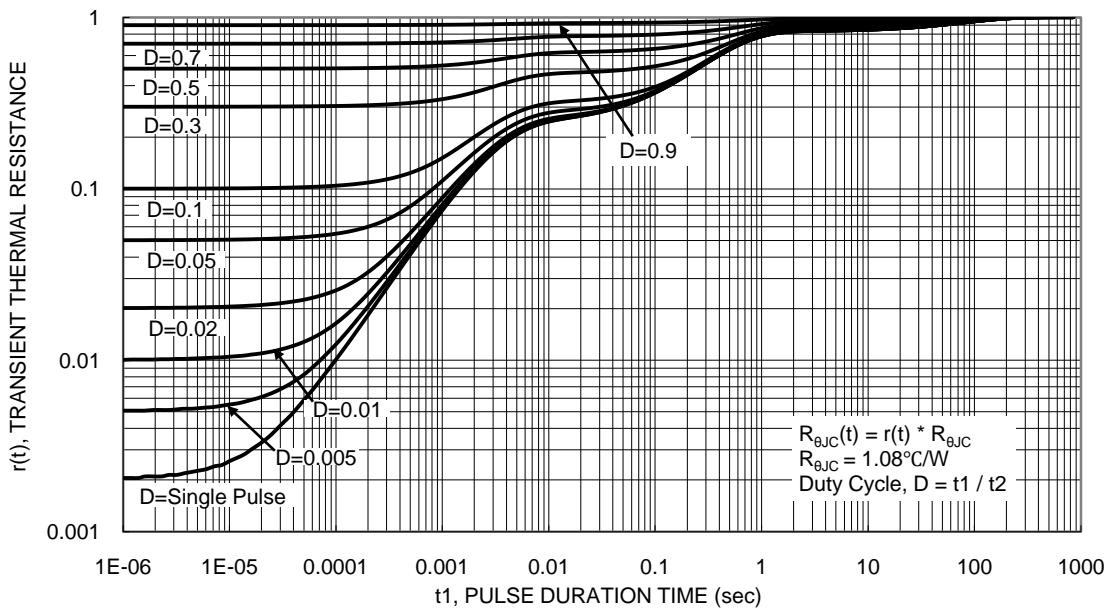
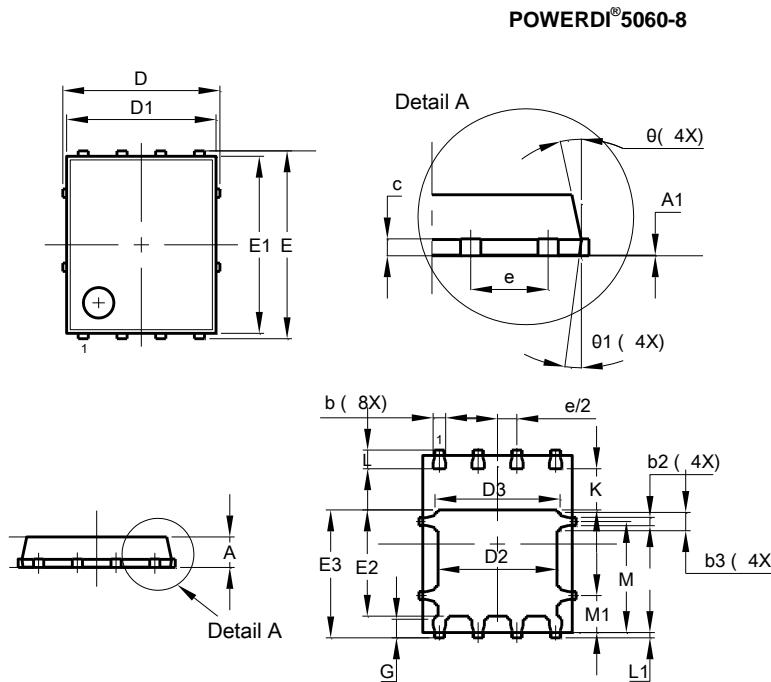


Figure 13. Transient Thermal Resistance

## Package Outline Dimensions

Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for the latest version.

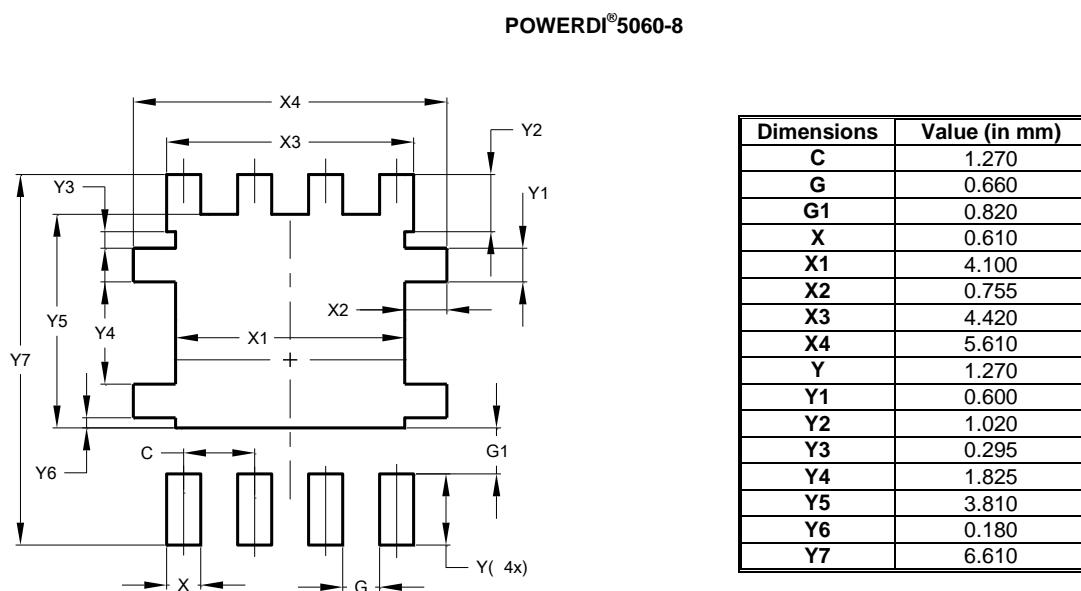


POWERDI®5060-8			
Dim	Min	Max	Typ
<b>A</b>	0.90	1.10	1.00
<b>A1</b>	0.00	0.05	—
<b>b</b>	0.33	0.51	0.41
<b>b2</b>	0.200	0.350	0.273
<b>b3</b>	0.40	0.80	0.60
<b>c</b>	0.230	0.330	0.277
<b>D</b>	5.15 BSC		
<b>D1</b>	4.70	5.10	4.90
<b>D2</b>	3.70	4.10	3.90
<b>D3</b>	3.90	4.30	4.10
<b>E</b>	6.15 BSC		
<b>E1</b>	5.60	6.00	5.80
<b>E2</b>	3.28	3.68	3.48
<b>E3</b>	3.99	4.39	4.19
<b>e</b>	1.27 BSC		
<b>G</b>	0.51	0.71	0.61
<b>K</b>	0.51	—	—
<b>L</b>	0.51	0.71	0.61
<b>L1</b>	0.100	0.200	0.175
<b>M</b>	3.235	4.035	3.635
<b>M1</b>	1.00	1.40	1.21
<b>Θ</b>	10°	12°	11°
<b>Θ1</b>	6°	8°	7°

All Dimensions in mm

## Suggested Pad Layout

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for the latest version.



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